Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/814,266	KATSUMATA ET AL	
Examiner	Art Unit	
Thien F. Tran	2811	

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Class	Subclass	Date	Examiner
257	336, 344	3/31/2005	тт
257	408, 900	3/31/2005	тт

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Subclass	Date	Examiner
336, 344	3/31/2005	π
408	3/31/2005	TT
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